SID4-SWIR

WAVE FRONT SENSOR



J. SPECIFICATIONS

| Wavelength range | 0.9 – 1.7μm |
|--------------------------------|------------------------------|
| Aperture dimensions | 9.60 x 7. 68 mm ² |
| Spatial resolution | 120 μm |
| Phase and intensity Sampling | 80 X 64 |
| Accuracy | 15 nm RMS |
| Resolution (Phase) | <2nm RMS |
| Acquisition rate | 120 fps |
| Real-time processing frequency | > 7 fps (full resolution) |
| Interface | Giga Ethernet |
| Dimensions | 100 x 55 x 63 mm |
| Weight | 455 g |

The SID4-SWIR wavefront sensor integrates Phasics patented technology with an In-GaAs detector. Thanks to its high spatial resolution and great sensitivity, it offers accurate wavefront measurement over its whole spectral range from 900 nm to 1.7μm.

The SID4-SWIR is an innovative solution for **testing SWIR lens** used in optical communications, inspection instruments or night vision in military and surveillance devices. It provides both MTF and aberrations at once.

The SID4-SWIR also enables characterizing SWIR sources like 1.55µm lasers or LEDs for laser guiding systems.

KEY FEATURES

- Extended spectral range from 0.9 to 1.7µm
- High resolution 80 X 64
- High sensitivity <2nm phase noise through the whole spectral range (compatible with low energy IR source)
- High stability
- Cooled detector
- Compact & Cost effective

Distribution in the UK & Ireland





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